

CERAMIC PACKAGING METHOD EMPLOYING FLIP-CHIP BONDING

Field of the Invention

5 The present invention relates to a packaging method of a semiconductor device; and, more particularly, a ceramic packaging method of a semiconductor device employing a flip-chip bonding.

10 Background of the Invention

 Fig. 1 shows a vertical sectional view for illustrating a conventional ceramic packaging process. Conventionally, a groove is formed in a ceramic body 100 and an adhesive 102 is coated on a bottom of the groove, such
15 that a chip 106 is adhered to the groove. A gold wire 104 serves connecting the chip 106 and the ceramic body 100 in a wire bonding, wherein the gold wire 104 is connected to a Cu pattern. Then the resultant construct is encapsulated by an
20 epoxy molding compound 108 in order to protect the gold wire 104 connecting the chip 106 to the ceramic body 100 against external environment. Thereafter, solder balls are attached to a chip bond pad (not shown) and a package assembly is completed.

25 However, in order to attach solder balls to the chip bond pad, the conventional packaging method involves too

complicated assembly processes such as a flux printing, a solder ball attachment, an IR (infrared) reflow, a flux cleaning and the like. Further, the conventional packaging method requires high manufacturing cost. Moreover, the
5 usage of the epoxy molding compound causes an environmental pollution by wastes thereof.

Summary of the Invention

10 There is, therefore, an object of the present invention to provide a ceramic packaging method of a semiconductor device capable of minimizing an electrically connected distance between a chip bond pad and a chip by employing a flip-chip bonding, thereby improving operational
15 characteristics of the semiconductor device.

In accordance with the present invention, there is provided a ceramic packaging method employing a flip-chip bonding, including the steps of: (a) forming a gold bump on a chip bond pad in a wafer; (b) dividing the wafer into a
20 plurality of chips by a die sawing; (c) aligning a Cu pattern and the gold bump on a ceramic package and adhering a bottom chip to the ceramic package through the Cu pattern and the gold bump; (d) adhering a top chip to the bottom chip by using an adhesive, thereby forming a bottom/top chip
25 structure of the bottom and top chip; (e) electrically connecting the chip bond pad to the bottom chip and the chip

bond pad to the top chip by interconnecting the bottom and the top chips; and (f) encapsulating interconnected portions of the bottom and the top chips.

5 Brief Description of the Drawings

The above and other objects and features of the present invention will become apparent from the following description of a preferred embodiment given in conjunction
10 with the accompanying drawings, in which:

Fig. 1 shows a vertical sectional view for illustrating a conventional ceramic packaging process;

Fig. 2 depicts a vertical sectional view for illustrating a ceramic packaging process employing a flip-
15 chip bonding in accordance with a preferred embodiment of the present invention; and

Fig. 3 represents a partially enlarged cross-sectional plan view for illustrating an alignment of a Cu pattern and a gold bump in the ceramic packaging process shown in Fig. 2
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Detailed Description of the Preferred Embodiment

Fig. 2 depicts a vertical sectional view for illustrating a ceramic packaging process employing a flip-
25 chip bonding in accordance with a preferred embodiment of the present invention.

A gold bump 200 is formed on a chip bond pad in a wafer, and thereafter, a die sawing is carried out to divide the wafer into respective chips.

5 A Cu pattern 202 and the gold bump 200 are aligned on a ceramic package 204 and then a bottom chip 206 is safely adhered to the ceramic package 204 in a thermal compression such that the bottom chip 206 is connected to the chip bond pad via the Cu pattern and the gold bump 200. The alignment of the Cu pattern 202 and the gold bump 200, which is marked
10 as "A" in Fig. 2, is exemplified in Fig. 3.

Referring to Fig. 3, the Cu pattern 202 is laid on the ceramic package 204 and then a gold plating is carried out with respect to the Cu pattern 202 in order to increase an adhesive strength between the Cu pattern 202 and the gold
15 bump 200. Further, a groove 300 is formed in the Cu pattern 202 to safely attach the gold bump 200.

Subsequently, a top chip 208 is adhered to a backside of the bottom chip 206 by using an adhesive 210, e.g., epoxy, polyimide tape or the like. Thereafter, the top chip 208 is
20 connected to the chip bond pad via the Cu pattern 202 and the gold bump 200 similarly as in the lower chip 206. Accordingly, an interconnection between the bottom chip 206 and the top chip 208 is achieved.

Thereafter, the resultant construct is encapsulated by
25 an insulating epoxy resin 212 to protect the interconnected portions against external environment and the insulating

epoxy resin 212 is cured to completed a package assembly.

Meanwhile, a heat emitter 214 is installed at a bottom portion of the ceramic package 204, i.e., a location where the bottom and the top chips 206 and 208 are faced, in order
5 to emit heat generated from the bottom and the top chips 206 and 208.

As described above, in accordance with the present invention, a groove is formed in a ceramic package and a bottom chip is safely adhered to the groove. Then the
10 bottom and an top chip are respectively adhered to a Cu pattern via a gold bump in a thermal compression. Therefore, an interconnection using a gold bump is also carried out between the top chip and the bottom chip, thereby completing a packaging process.

15 Accordingly, a packaging space can be minimized because a Cu pattern instead of an existing DIP type lead frame is used in packaging a semiconductor device. Further, an electrically connected distance between a chip bond pad and a chip is minimized, thereby increasing operational
20 characteristics of the semiconductor device while reducing manufacturing cost thereof. Moreover, since an epoxy molding compound is used for protecting the chip against external environment, an environmental pollution by wastes of the epoxy molding compound can be reduced.

25 While the invention has been shown and described with respect to the preferred embodiments, it will be understood

by those skilled in the art that various changes and modifications may be made without departing from the spirit and scope of the invention as defined in the following claims.